IRFM350 (JANTX2N7227)

PD-90491G

Power MOSFET
Thru-Hole (TO-254AA)
400V, 14A, N-channel, HEXFET™ MOSFET Technology

Features

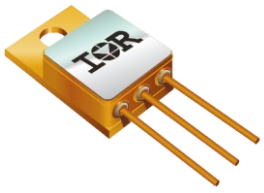
- Simple drive requirements
- Hermetically sealed
- Electrically isolated
- Dynamic dv/dt rating
- Light weight
- Ceramic eyelets
- ESD rating: class 2 per MIL-STD-750, Method 1020

Potential Applications

- DC-DC converter
- Motor drives

Product Summary

- **BV_{DSS}:** 400V
- **I_D:** 14A
- **$R_{DS(on),max}$:** 315mΩ
- **$Q_{G,max}$:** 110nC
- **REF:** MIL-PRF-19500/592



TO-254AA

Product Validation

Qualified to JANTXV screening flow according to MIL-PRF-19500 for high-reliability applications

Description

IR HiRel HEXFET™ technology is advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET™ transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, fast switching and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET™ transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink. This improves thermal efficiency and reduces drain capacitance.

Ordering Information

Table 1 Ordering options

Part number	Package	Screening Level
IRFM350	TO-254AA	COTS
JANTX2N7227	TO-254AA	JANTX
JANTXV2N7227	TO-254AA	JANTXV

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1 Absolute Maximum Ratings

Table 2 Absolute Maximum Ratings

Symbol	Parameter	Value	Unit
I_{D1} @ V_{GS} = 10V, T_C = 25°C	Continuous Drain Current	14	A
I_{D2} @ V_{GS} = 10V, T_C = 100°C	Continuous Drain Current	9.0	A
I_{DM} @ T_C = 25°C	Pulsed Drain Current [1]	56	A
P_D @ T_C = 25°C	Maximum Power Dissipation	150	W
	Linear Derating Factor	1.2	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy [2]	700	mJ
I_{AR}	Avalanche Current [1]	14	A
E_{AR}	Repetitive Avalanche Energy [1]	15	mJ
dv/dt	Peak Diode Reverse Recovery [3]	4.0	V/ns
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C
	Lead Temperature	300 (0.063 in. /1.6 mm from case for 10s)	
	Weight	9.3 (Typical)	g

[1] Repetitive Rating; Pulse width limited by maximum junction temperature.

[2] V_{DD} = 50V, starting T_J = 25°C, L = 7.1mH, Peak I_L = 14A, V_{GS} = 10V

[3] $I_{SD} \leq$ 14A, di/dt ≤ 145A/µs, $V_{DD} \leq$ 400V, $T_J \leq$ 150°C

2 Device Characteristics

2.1 Electrical Characteristics

Table 3 Electrical Characteristics @ T_j = 25°C (Unless Otherwise Specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	400	—	—	V	V_{GS} = 0V, I_D = 1.0mA
$\Delta BV_{DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.46	—	V/°C	Reference to 25°C, I_D = 1.0mA
$R_{DS(on)}$	Static Drain-to-Source On-State Resistance	—	—	315	mΩ	V_{GS} = 10V, I_{D2} = 9.0A [1]
		—	—	415		V_{GS} = 10V, I_{D1} = 14A [1]
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	V_{DS} = V_{GS}, I_D = 250µA
Gfs	Forward Transconductance	6.0	—	—	S	V_{DS} = 15V, I_{D2} = 9.0A
I_{DSS}	Zero Gate Voltage Drain Current	—	—	25	µA	V_{DS} = 320V, V_{GS} = 0V
		—	—	250		V_{DS} = 320V, V_{GS} = 0V,T_J = 125°C
I_{GSS}	Gate-to-Source Leakage Forward	—	—	100	nA	V_{GS} = 20V
	Gate-to-Source Leakage Reverse	—	—	-100		V_{GS} = -20V
Q_G	Total Gate Charge	—	—	110	nC	I_{D1} = 14A V_{DS} = 200V V_{GS} = 10V
Q_{GS}	Gate-to-Source Charge	—	—	18		
Q_{GD}	Gate-to-Drain (‘Miller’) Charge	—	—	65		
$t_{d(on)}$	Turn-On Delay Time	—	—	35	ns	I_{D1} = 14A ** V_{DD} = 200V R_G = 2.35Ω V_{GS} = 10V
t_r	Rise Time	—	—	190		
$t_{d(off)}$	Turn-Off Delay Time	—	—	170		
t_f	Fall Time	—	—	130		
L_s +L_D	Total Inductance	—	6.8	—	nH	Measured from Drain lead (6mm / 0.25 in from package) to Source lead (6mm/ 0.25 in from package) with Source wire internally bonded from Source pin to Drain pad
C_{iss}	Input Capacitance	—	1300	—	pF	V_{GS} = 0V V_{DS} = 25V f = 1.0MHz
C_{oss}	Output Capacitance	—	400	—		
C_{rss}	Reverse Transfer Capacitance	—	130	—		

** Switching speed maximum limits are based on manufacturing test equipment and capability.

[1] Pulse width ≤ 300 µs; Duty Cycle ≤ 2%

2.2 Source-Drain Diode Ratings and Characteristics

Table 4 Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	14	A	
I_{SM}	Pulsed Source Current (Body Diode) [1]	—	—	56	A	
V_{SD}	Diode Forward Voltage	—	—	1.7	V	T_J = 25°C, I_S = 14A, V_{GS} = 0V [2]
t_{rr}	Reverse Recovery Time	—	—	1200	ns	T_J = 25°C, I_F = 14A, V_{DD} ≤ 50V di/dt = 100A/µs
Q_{rr}	Reverse Recovery Charge	—	7.3	—	µC	
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)				

2.3 Thermal Characteristics

Table 5 Thermal Resistance

Symbol	Parameter	Min.	Typ.	Max.	Unit
$R_{\theta JC}$	Junction-to-Case	—	—	0.83	°C/W
$R_{\theta CS}$	Case-to-Sink	—	0.21	—	
$R_{\theta JA}$	Junction-to-Ambient (Typical socket mount)	—	—	48	

[1] Repetitive Rating; Pulse width limited by maximum junction temperature.

[2] Pulse width ≤ 300 µs; Duty Cycle ≤ 2%

3 Electrical Characteristics Curves

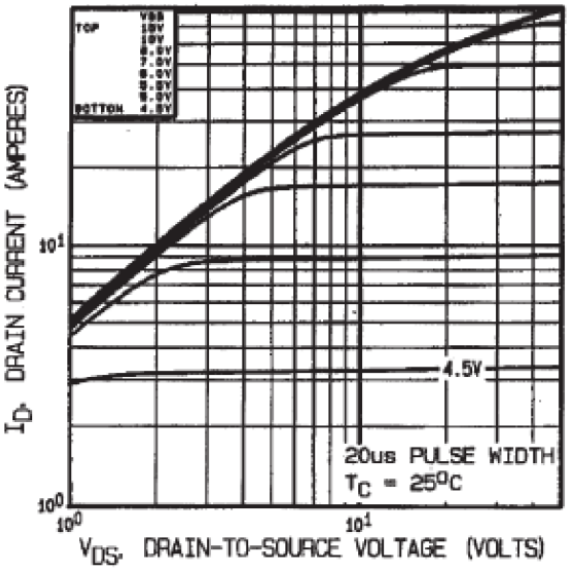


Figure 1 **Typical Output Characteristics**

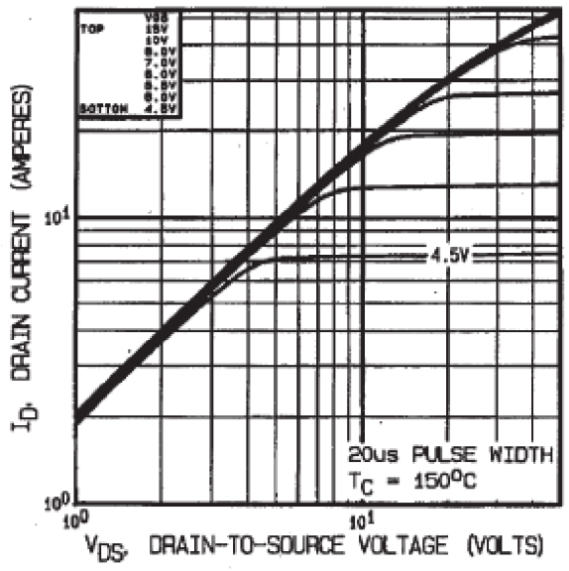


Figure 2 **Typical Output Characteristics**

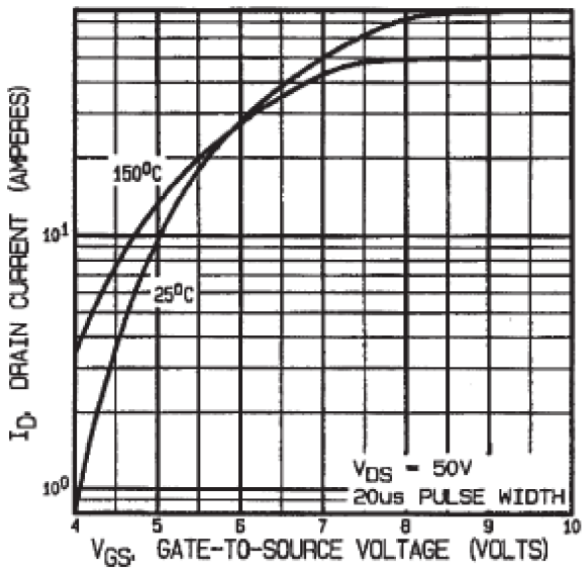


Figure 3 **Typical Transfer Characteristics**

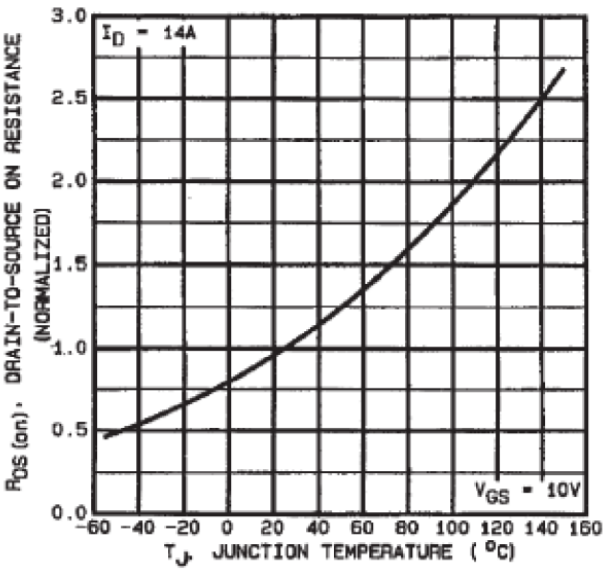


Figure 4 **Normalized On-Resistance Vs. Temperature**

Electrical Characteristics Curves

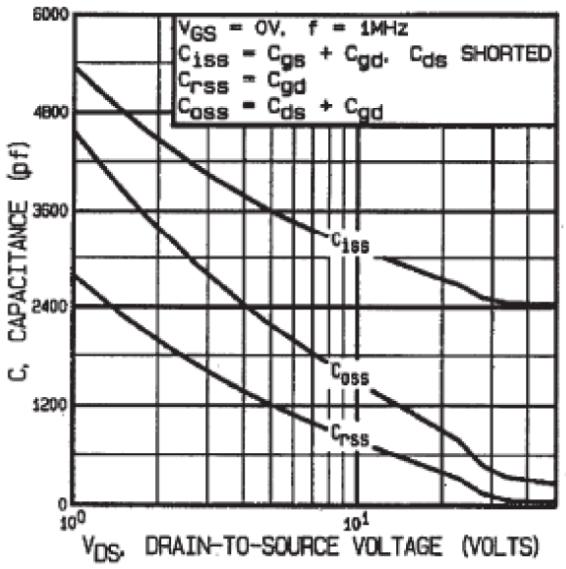


Figure 5 Typical Capacitance Vs. Drain-to-Source Voltage

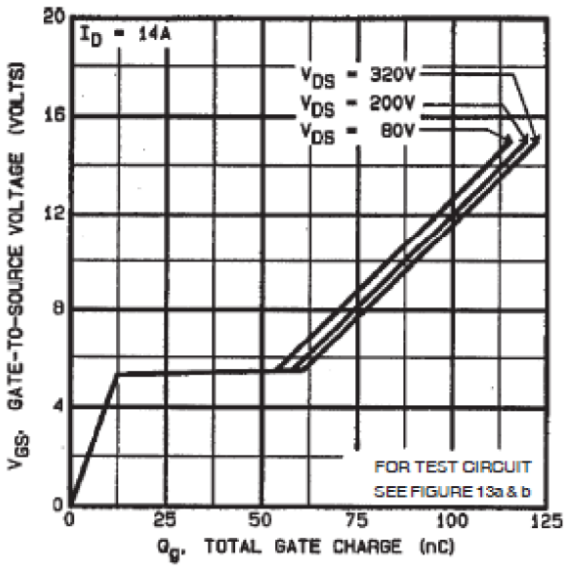


Figure 6 Typical Gate Charge Vs. Gate-to-Source Voltage

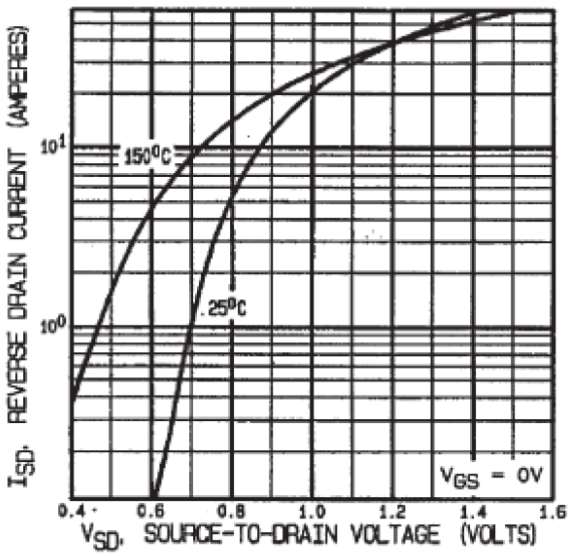


Figure 7 Typical Source-Drain Current Vs. Diode Forward Voltage

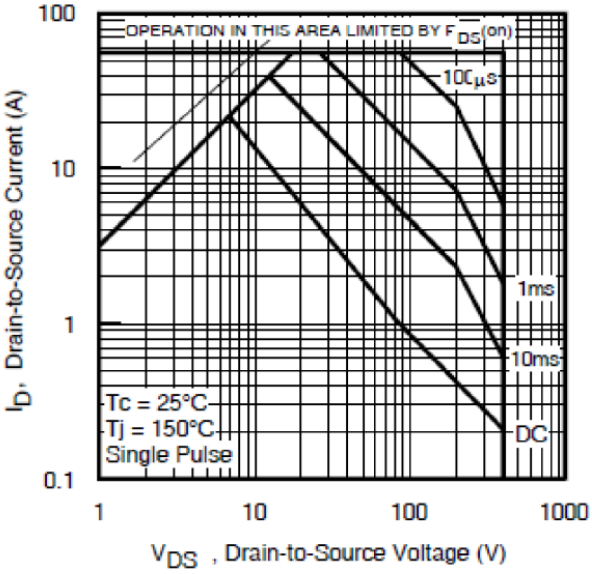


Figure 8 Maximum Safe Operating Area

Electrical Characteristics Curves

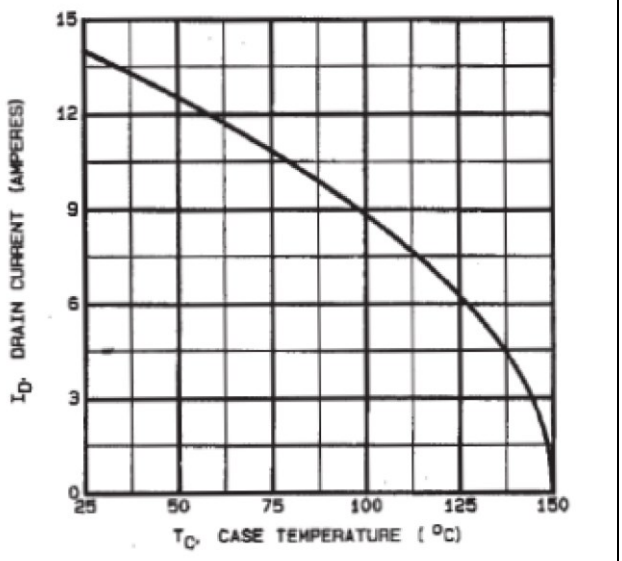


Figure 9 Maximum Drain Current Vs. Case Temperature

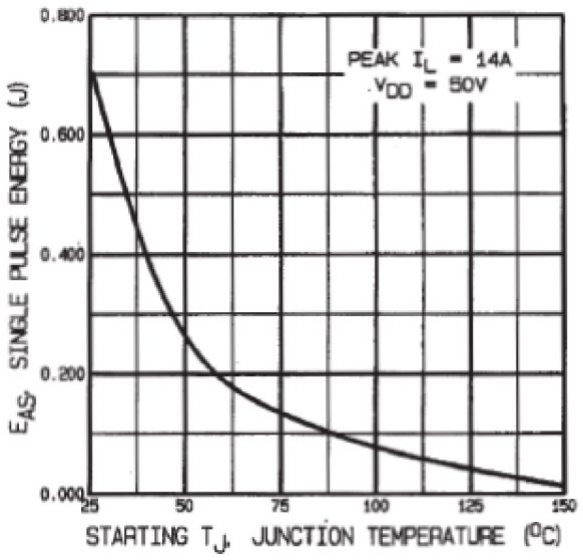


Figure 10 Maximum Avalanche Energy Vs. Junction Temperature

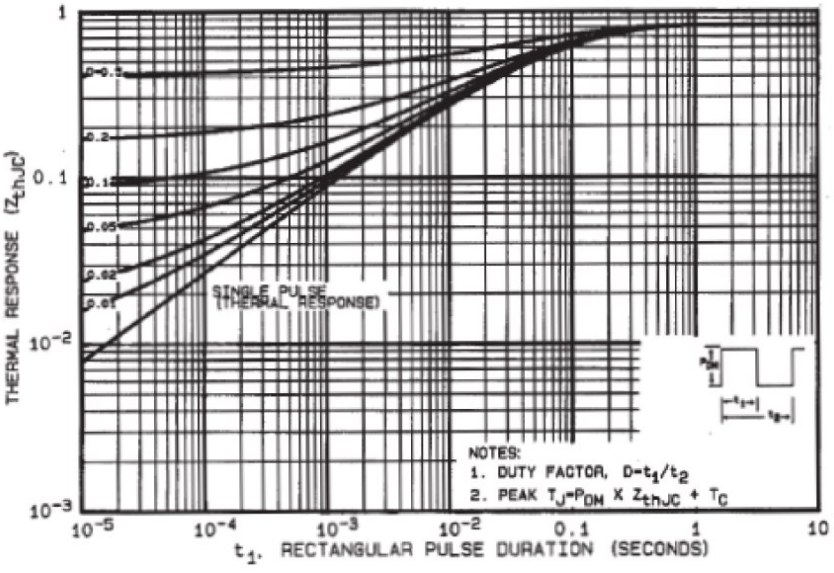


Figure 11 Maximum Effective Transient Thermal Impedance, Junction-to-Case

4 Test Circuits

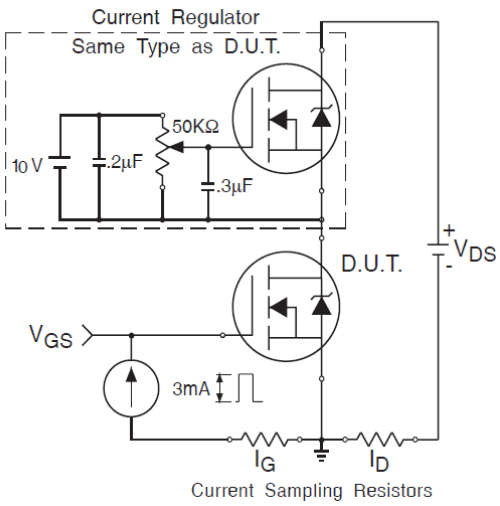


Figure 12 Gate Charge Test Circuit

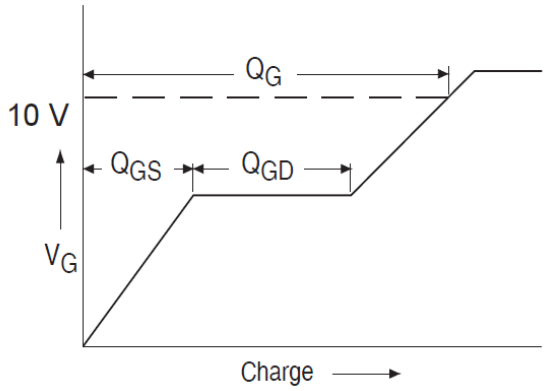


Figure 13 Gate Charge Waveform

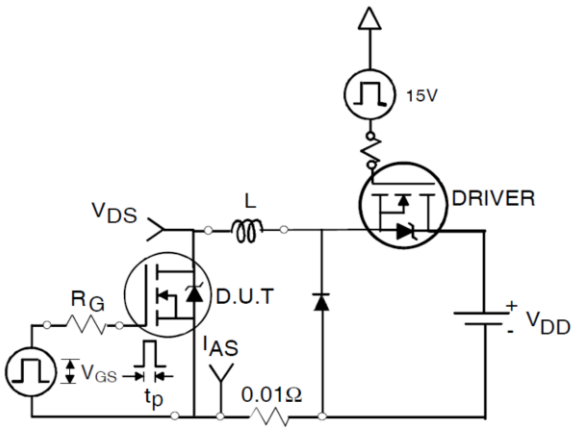


Figure 14 Unclamped Inductive Test Circuit

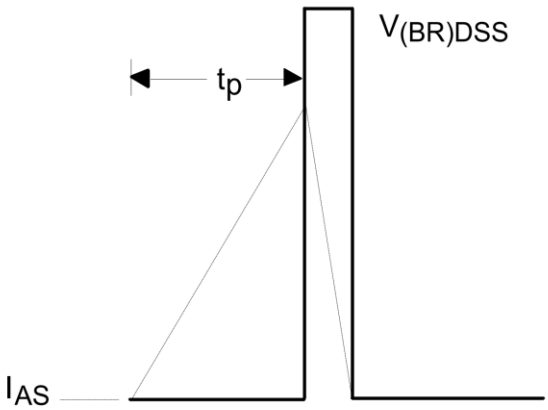


Figure 15 Unclamped Inductive Waveform

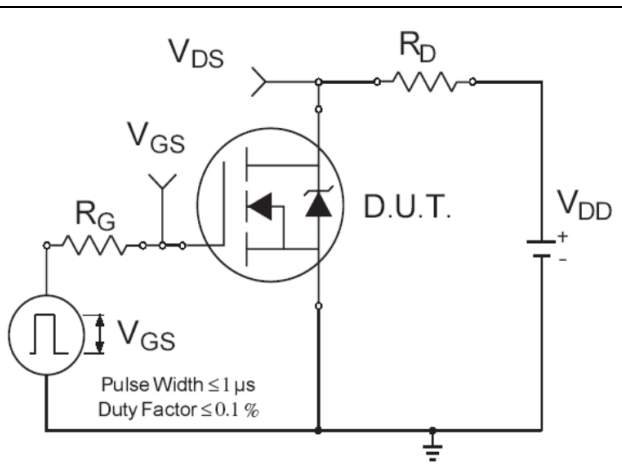


Figure 16 Switching Time Test Circuit

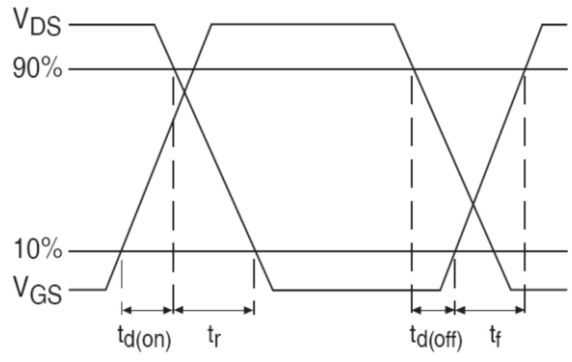
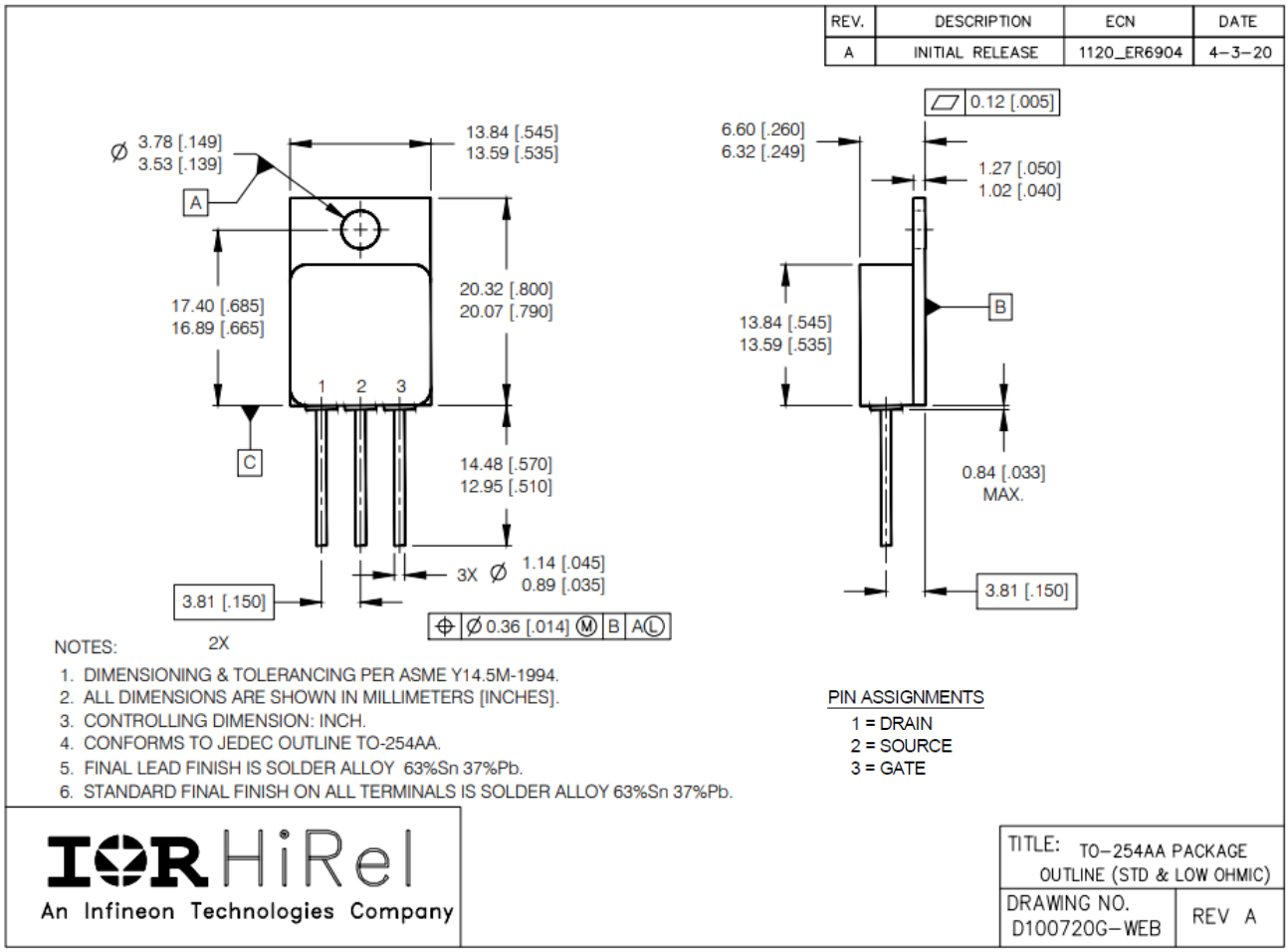


Figure 17 Switching Time Waveforms

5 Package Outline

Note: For the most updated package outline, please see the website: TO-254AA



BERYLLIA WARNING PER MIL-PRF-19500

Package containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

Revision history

Document version	Date of release	Description of changes
Rev D	01/14/2002	Datasheet (PD-90491)
Rev E	07/19/2024	Updated based on ECN-14932
Rev F	04/30/2021	Updated based on ECN-1120_08526
Rev G	08/06/2024	Updated based on ECN-1120_10008

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